

## A Pairwise Test Suite Generator Based on Melody Search Algorithm

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**Abstract:** Melody Search Algorithm (MS) has been adopted to solve many optimization problems such as combinatorial testing. This paper aims to introduce MS as a pairwise testing strategy called a Pairwise Test suite generator based Melody Search Algorithm (PTMS). A pairwise testing is an operative approach in the combinatorial test suite construction. It will minimize the constructed test suite size to save the testing time with effective defects being detected. The proposed strategy generates the test suite with real-valued variables. A comparative evaluation revealed that the PTMS is efficient in constructing a minimum test suite with the existing strategies.

**Key words:** Pairwise testing, Melody Search (MS) algorithm, test data generation, combinatorial testing, variables

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### INTRODUCTION

In this information technology era, there is a huge influence of high technology and artificial intelligence when creating new software products. This new method provides an effective way of bringing high-quality software products to the end user. Many fields also rely on this method, especially in the Research and Development (R and D) area. Evidently, many manual processes are being performed by certain software products or artificial intelligence. Basically, every product created is operated by the combination of hardware and software to implement each feature (Perrouin *et al.*, 2012). There is a close relationship between hardware and software; both play important roles to avoid failure.

Failure of products will occur when a human action produces some error or bug in the software and this will lead to the defects which will cause a malfunction when executed. This problem can cause serious damage to system function, loss of time especially for a critical system and higher cost of maintenance. Therefore, software testing takes first priority in any Software Development Life Cycle (SDLC) in order to ensure high quality software and to minimize the occurrence of failure of the software.

Software testing is defined as the process of executing a program on finding possible errors and validating the software or system against its specification

(Myers *et al.*, 1979). It is known from the studies of seven principles that exhaustive testing is impossible to execute all the test cases for a real software product (Wang *et al.*, 2013). A complete testing is impossible because there are many possible combinations of inputs and pre-condition test case for software.

Pairwise testing is an effective combinatorial method of software testing used to minimize the number of test case that is needed for input parameters to a system and the interactions between two input parameters values (McCaffrey, 2010). This strategy generates test cases that cover all the possible input combinations in order to include the test data and to reduce the possibilities of faults due to interaction (Perrouin *et al.*, 2012). There are many pairwise testing strategies that are available such as Simulated Annealing (SA) (Cohen *et al.*, 2007), Automatic Efficient Test Generator (AETG) (Cohen *et al.*, 1997), Genetic Algorithm (GA) (Flores and Cheon, 2011; McCaffrey, 2010) Ant Colony Algorithm (ACA) (Shiba *et al.*, 2004), Bat Pairwise Test Strategy (BPTS) (Alsariera *et al.*, 2015), Harmony Search Strategy (PHSS) (Alsewari and Zamli, 2012), In-Parameter-Order (IPO) (Lei *et al.*, 2007, 2008) and Intersection Residual Pair Set (IRPS) (Younis *et al.*, 2008, 2009). Although, the listed strategies are useful, none of them can give assurance in producing optimum results for every case study. It should be noted that some of the existing pairwise testing strategies are based on optimization algorithms such as GA, HSS, ACA, BPTS and SA. Therefore,